

<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/519,227	CHOI ET AL.
Examiner	Art Unit	
John P. Sheehan	1793	

<b>INTERFERENCE SEARCHED</b>			
Class	Subclass	Date	Examiner
PG Pub	Search	6/15/2008	JPS